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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
09/741,804	12/22/2000	Jun Hayakawa	501.39395X00	9059
20457	7590	09/27/2004	EXAMINER	
ANTONELLI, TERRY, STOUT & KRAUS, LLP 1300 NORTH SEVENTEENTH STREET SUITE 1800 ARLINGTON, VA 22209-9889			RENNER, CRAIG A	
			ART UNIT	PAPER NUMBER
			2652	

DATE MAILED: 09/27/2004

Please find below and/or attached an Office communication concerning this application or proceeding.

Office Action Summary

Application No.

09/741,804

Applicant(s)

HAYAKAWA ET AL.

Examiner

Craig A. Renner

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-- The MAILING DATE of this communication appears on the cover sheet with the correspondence address --

Period for Reply

A SHORTENED STATUTORY PERIOD FOR REPLY IS SET TO EXPIRE 3 MONTH(S) FROM THE MAILING DATE OF THIS COMMUNICATION.

- Extensions of time may be available under the provisions of 37 CFR 1.136(a). In no event, however, may a reply be timely filed after SIX (6) MONTHS from the mailing date of this communication.
- If the period for reply specified above is less than thirty (30) days, a reply within the statutory minimum of thirty (30) days will be considered timely.
- If NO period for reply is specified above, the maximum statutory period will apply and will expire SIX (6) MONTHS from the mailing date of this communication.
- Failure to reply within the set or extended period for reply will, by statute, cause the application to become ABANDONED (35 U.S.C. § 133). Any reply received by the Office later than three months after the mailing date of this communication, even if timely filed, may reduce any earned patent term adjustment. See 37 CFR 1.704(b).

Status

- 1) ☒ Responsive to communication(s) filed on 30 July 2004.
- 2a) ☐ This action is FINAL. 2b) ☒ This action is non-final.
- 3) ☐ Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under *Ex parte Quayle*, 1935 C.D. 11, 453 O.G. 213.

Disposition of Claims

- 4) ☒ Claim(s) 1,3,4 and 6-14 is/are pending in the application.
- 4a) Of the above claim(s) _____ is/are withdrawn from consideration.
- 5) ☐ Claim(s) _____ is/are allowed.
- 6) ☒ Claim(s) 1,3,4 and 6-14 is/are rejected.
- 7) ☐ Claim(s) _____ is/are objected to.
- 8) ☐ Claim(s) _____ are subject to restriction and/or election requirement.

Application Papers

- 9) ☐ The specification is objected to by the Examiner.
- 10) ☐ The drawing(s) filed on _____ is/are: a) ☐ accepted or b) ☐ objected to by the Examiner.
Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).
Replacement drawing sheet(s) including the correction is required if the drawing(s) is objected to. See 37 CFR 1.121(d).
- 11) ☐ The oath or declaration is objected to by the Examiner. Note the attached Office Action or form PTO-152.

Priority under 35 U.S.C. § 119

- 12) ☐ Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).
- a) ☐ All b) ☐ Some * c) ☐ None of:
- ☐ Certified copies of the priority documents have been received.
 - ☐ Certified copies of the priority documents have been received in Application No. _____.
 - ☐ Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)).

* See the attached detailed Office action for a list of the certified copies not received.

Attachment(s)

- | | |
|---|---|
| 1) <input checked="" type="checkbox"/> Notice of References Cited (PTO-892) | 4) <input type="checkbox"/> Interview Summary (PTO-413) |
| 2) <input type="checkbox"/> Notice of Draftsperson's Patent Drawing Review (PTO-948) | Paper No(s)/Mail Date. _____ |
| 3) <input type="checkbox"/> Information Disclosure Statement(s) (PTO-1449 or PTO/SB/08) | 5) <input type="checkbox"/> Notice of Informal Patent Application (PTO-152) |
| Paper No(s)/Mail Date _____ | 6) <input type="checkbox"/> Other: _____ |

DETAILED ACTION

Continued Examination Under 37 CFR 1.114

1. A request for continued examination under 37 CFR 1.114, including the fee set forth in 37 CFR 1.17(e), was filed in this application after final rejection. Since this application is eligible for continued examination under 37 CFR 1.114, and the fee set forth in 37 CFR 1.17(e) has been timely paid, the finality of the previous Office action has been withdrawn pursuant to 37 CFR 1.114. Applicant's submission filed on 30 July 2004 has been entered.

Claim Rejections - 35 USC § 102

2. The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless –

(e) the invention was described in (1) an application for patent, published under section 122(b), by another filed in the United States before the invention by the applicant for patent or (2) a patent granted on an application for patent by another filed in the United States before the invention by the applicant for patent, except that an international application filed under the treaty defined in section 351(a) shall have the effects for purposes of this subsection of an application filed in the United States only if the international application designated the United States and was published under Article 21(2) of such treaty in the English language.

3. Claims 1, 3-4, and 6-14 are rejected under 35 U.S.C. 102(e) as being anticipated by Pinarbasi (US 6,268,985).

With respect to claims 1, 3-4, 6-7, 9, and 11-12, Pinarbasi (US 6,268,985) teaches a magnetic head (40) having a magnetoresistive film (74/500, for instance)

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comprising an anti-ferromagnetic layer (218), a ferromagnetic pinned layer (206), a non-magnetic intermediate layer (204), a soft magnetic free layer (208), a non-magnetic conductive oxidized stopper layer (504, lines 5-6 in column 9, for instance, i.e., "ruthenium" is a non-magnetic and conductive oxidized stopper layer, as admitted by applicant's own disclosure in lines 8-10 on page 5, for instance), and an oxide protective layer (506 and/or 508) of metal selected from Ta, Nb, Ti, Hf, W or an alloy thereof (line 65 in column 8 thru line 3 in column 9, for instance, i.e., layer 506 includes " Ta_2O_3 ", and/or lines 9-15 in column 9, for instance, i.e., layer 508 includes " Ta_2O_3 ") laminated in this order (as shown in FIG. 15, for instance) on a substrate (42) [as per claim 1]; wherein the thickness of the metal oxide protective layer is 1.0 nm or less (lines 7-8 in column 9, for instance, i.e., "between 5 Å to 50 Å" includes values within the range of "1.0 nm or less") [as per claim 3]; wherein an intermediate layer coupling field showing a magnitude of ferromagnetic coupling between the ferromagnetic pinned layer and the soft magnetic free layer is substantially zero (as shown in FIG. 15, for instance, i.e., an intermediate layer coupling field showing a magnitude of ferromagnetic coupling between the ferromagnetic pinned layer and the soft magnetic free layer would be substantially zero due to the structure depicted in FIG. 15 and accompanying detailed description thereof) [as per claims 4 and 6-7]; wherein the non-magnetic and conductive oxidized stopper layer substantially prevents at least one of diffusion of oxygen from the metal oxide protective layer and propagation of stresses caused by oxides with respect to the soft magnetic free layer and degradation of a soft magnetic characteristic of the soft magnetic free layer (lines 5-6 in column 9, for instance, i.e., "ruthenium" prevents at

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least one of diffusion of oxygen from the metal oxide protective layer and propagation of stresses caused by oxides with respect to the soft magnetic free layer and degradation of a soft magnetic characteristic of the soft magnetic free layer) [as per claim 9]; wherein the non-magnetic and conductive oxidized stopper layer has a thickness so that an intermediate layer coupling field showing a magnitude of ferromagnetic coupling between the ferromagnetic pinned layer and the soft magnetic free layer is substantially zero (lines 5-6 in column 9, for instance, i.e., "ruthenium... between 3 Å to 30 Å" will cause an intermediate layer coupling field showing a magnitude of ferromagnetic coupling between the ferromagnetic pinned layer and the soft magnetic free layer to be substantially zero) [as per claim 11]; and wherein the thickness of the non-magnetic and conductive oxidized stopper layer enables a change of resistance to be maximized (lines 5-6 in column 9, for instance, i.e., "ruthenium... between 3 Å to 30 Å" will enable a change of resistance to be maximized) [as per claim 12].

With respect to claims 8, 10, and 13-14, Pinarbasi (US 6,268,985) teaches a magnetic recording apparatus (30) including a magnetic recording medium (34) for recording information, a magnetic head (40) having a magnetoresistive film (72/500, for instance) comprising an anti-ferromagnetic layer (218), a ferromagnetic pinned layer (206), a non-magnetic intermediate layer (204), a soft magnetic free layer (208), a non-magnetic conductive oxidized stopper layer (504, lines 5-6 in column 9, for instance, i.e., "ruthenium" is a non-magnetic and conductive oxidized stopper layer, as admitted by applicant's own disclosure in lines 8-10 on page 5, for instance), and an oxide protective layer (506 and/or 508) of metal selected from Ta, Nb, Ti, Hf, W or an alloy

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thereof (line 65 in column 8 thru line 3 in column 9, for instance, i.e., layer 506 includes " Ta_2O_3 ", and/or lines 9-15 in column 9, for instance, i.e., layer 508 includes " Ta_2O_3 ") laminated in this order (as shown in FIG. 15, for instance) on a substrate (part of 42), a head slider (rest of 42) for holding the magnetic head, an actuator (includes 46) for guiding the head slider to a predetermined recording position on the recording medium, a spindle motor (36) rotating the recording medium and a signal processing system (50) for processing information read out of the magnetic recording medium [as per claim 8]; wherein the non-magnetic conductive oxidized stopper layer substantially prevents at least one of diffusion of oxygen from the metal oxide protective layer and propagation of stresses caused by oxides with respect to the soft magnetic free layer and degradation of a soft magnetic characteristic of the soft magnetic free layer (lines 5-6 in column 9, for instance, i.e., "ruthenium" prevents at least one of diffusion of oxygen from the metal oxide protective layer and propagation of stresses caused by oxides with respect to the soft magnetic free layer and degradation of a soft magnetic characteristic of the soft magnetic free layer) [as per claim 10]; wherein the non-magnetic and conductive oxidized stopper layer has a thickness so that an intermediate layer coupling field showing a magnitude of ferromagnetic coupling between the ferromagnetic pinned layer and the soft magnetic free layer is substantially zero (lines 5-6 in column 9, for instance, i.e., "ruthenium... between 3 Å to 30 Å" will cause an intermediate layer coupling field showing a magnitude of ferromagnetic coupling between the ferromagnetic pinned layer and the soft magnetic free layer to be substantially zero) [as per claim 13]; and wherein the thickness of the non-magnetic and conductive oxidized stopper layer enables a

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change of resistance to be maximized (lines 5-6 in column 9, for instance, i.e., "ruthenium... between 3 Å to 30 Å" will enable a change of resistance to be maximized) [as per claim 14].

4. Claim 1 is rejected under 35 U.S.C. 102(e) as being anticipated by Hasegawa et al. (US 6,643,107).

Hasegawa et al. (US 6,643,107) teach a magnetic head (FIG. 1, for instance) having a magnetoresistive film (16) comprising an anti-ferromagnetic layer (11), a ferromagnetic pinned layer (12), a non-magnetic intermediate layer (13), a soft magnetic free layer (14), a non-magnetic conductive oxidized stopper layer (B1, lines 39-41 in column 21, for instance, i.e., any one of "Au, Ag, and Cu" is a non-magnetic and conductive oxidized stopper layer material, as admitted by applicant's own disclosure in lines 8-10 on page 5, for instance), and an oxide protective layer (15a) of metal selected from Ta, Nb, Ti, Hf, W or an alloy thereof (lines 38-40 in column 19, for instance, i.e., "Ta-oxide") laminated in this order (as shown in FIG. 1, for instance) on a substrate (10).

Response to Arguments

5. Applicant's arguments filed 30 July 2004 have been fully considered but they are not persuasive.

The applicant argues that "Pinarbasi does not teach... the combination of the oxide protective layer and the non-magnetic conductive oxide stopper layer to improve ΔR of the spin valve film" and references "Fig. 12", "Fig. 13" and "Charts A & B" for

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support thereof. This argument, however, is not found to be persuasive for the following: Firstly, it is noted that neither independent claim calls for "the combination of the oxide protective layer and the non-magnetic conductive oxide stopper layer to improve ΔR of the spin valve film." Only dependent claims 12 and 14 call for "wherein the thickness of the non-magnetic and conductive oxidized stopper layer enables a change of resistance (ΔR) to be maximized." Secondly, the examiner relies upon magnetoresistive film 500 shown in FIG. 15 and represented in CHART D in the rejection(s), supra, so arguments concerning FIGS. 12 & 13 and CHARTS A & B have no relevance to the rejection(s) at hand. Lastly, as the non-magnetic and conductive oxidized stopper layer material thickness taught by Pinarbasi is the same as that claimed/described by applicant, it is seen that it will likewise maximize change of resistance to some extent.

The applicant also argues that "Pinarbasi does not disclose that the thickness of the metal oxide layer is 1.0 nm or less, that the interlayer coupling field showing the magnitude of the ferromagnetic coupling between the ferromagnetic pinned layer and the soft magnetic free layer is substantially zero, and that the thickness of the non-magnetic conductive oxidized stopper layer is sufficient to provide a substantially zero intermediate layer coupling field." This argument, however, is not found to be persuasive as Pinarbasi does teach that the thickness of the metal oxide layer is 1.0 nm or less (lines 7-8 in column 9, for instance, i.e., "between 5 Å to 50 Å" includes values within the range of "1.0 nm or less"), that the intermediate layer coupling field showing the magnitude of ferromagnetic coupling between the ferromagnetic pinned layer and

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the soft magnetic free layer is substantially zero (as shown in FIG. 15, for instance, i.e., the intermediate layer coupling field showing the magnitude of ferromagnetic coupling between the ferromagnetic pinned layer and the soft magnetic free layer would be substantially zero due to the structure depicted in FIG. 15 and accompanying detailed description thereof as it is structurally the same as the claimed/described), and that the thickness of the non-magnetic conductive oxidized stopper layer is sufficient to provide a substantially zero intermediate layer coupling field (lines 5-6 in column 9, for instance, i.e., "ruthenium... between 3 Å to 30 Å" is sufficient to provide a substantially zero intermediate layer coupling field as it is structurally the same as the claimed/described).

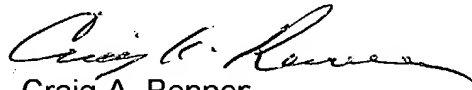
Conclusion

6. Any inquiry concerning this communication or earlier communications from the examiner should be directed to Craig A. Renner whose telephone number is (703) 308-0559. The examiner can normally be reached on Tuesday-Friday 7:30 AM - 6:00 PM.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Hoa T. Nguyen can be reached on (703) 305-9687. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

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Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see <http://pair-direct.uspto.gov>. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).



Craig A. Renner
Primary Examiner
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